



FQB22P10TM F085

100V P-Channel MOSFET

General Description

These P-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

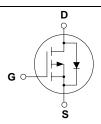
This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for low voltage applications such as audio amplifier, high efficiency switching DC/DC converters, and DC motor control.

Features

- -22A, -100V, $R_{DS(on)} = 0.125\Omega$ @ $V_{GS} = -10 \text{ V}$
- Low gate charge (typical 40 nC)
- Low Crss (typical 160 pF)
- Fast switching
- 100% avalanche tested
- · Improved dv/dt capability
- · 175°C maximum junction temperature rating
- Qualified to AEC Q101
- RoHS Compliant



D²-PAK FQB Series



Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		FQB22P10TM_F085	Units
V _{DSS}	Drain-Source Voltage		-100	V
I _D	Drain Current - Continuous (T _C = 25°C)		-22	Α
	- Continuous (T _C = 100°C	C)	-15.6	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	-88	А
V _{GSS}	Gate-Source Voltage		±30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	710	mJ
I _{AR}	Avalanche Current	(Note 1)		Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	12.5	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		-6.0	V/ns
P _D	Power Dissipation (T _A = 25°C) *		3.75	W
	Power Dissipation (T _C = 25°C)		125	W
	- Derate above 25°C		0.83	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +175	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

* When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		1.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-100			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = -250 μA, Referenced to	o 25°C	-0.1		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -100 V, V _{GS} = 0 V			-1	μА
		V _{DS} = -80 V, T _C = 125°C			-10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = -30 V, V _{DS} = 0 V			-100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
On Cha	aracteristics					•
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-2.0		-4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = -10 V, I _D = -11 A		0.096	0.125	Ω
9 _{FS}	Forward Transconductance	V _{DS} = -40 V, I _D = -11 A	(Note 4)	13.5		S
Dynam C _{iss} C _{oss}	ic Characteristics Input Capacitance Output Capacitance	V _{DS} = -25 V, V _{GS} = 0 V, f = 1.0 MHz		1170 460	1500 600	pF pF
C _{rss}	Reverse Transfer Capacitance			160	200	pF pF
Orss	Neverse Transier Capacitance			100	200	ρι
Switch	ing Characteristics	T				
t _{d(on)}	Turn-On Delay Time	V_{DD} = -50 V, I_{D} = -22 A, R_{G} = 25 Ω		17	45	ns
t _r	Turn-On Rise Time			170	350	ns
t _{d(off)}	Turn-Off Delay Time			60	130	ns
t _f	Turn-Off Fall Time	1)	lote 4, 5)	110	230	ns
Qg	Total Gate Charge	$V_{DS} = -80 \text{ V}, I_{D} = -22 \text{ A},$		40	50	nC
Q _{gs}	Gate-Source Charge	V _{GS} = -10 V		7.0		nC
Q _{gd}	Gate-Drain Charge	1)	lote 4, 5)	21		nC
Drain-S	Source Diode Characteristics ar	nd Maximum Ratings				
	Maximum Continuous Drain-Source Diode Forward Current				-22	Α
Is	Maximum Continuous Diam-Source Dic	Maximum Pulsed Drain-Source Diode Forward Current				
I _S					-88	Α
I _S I _{SM} V _{SD}					-88 -4.0	A V

Q_{rr}

Reverse Recovery Charge

 dI_F / dt = 100 A/ μ s

(Note 4)

0.6

μС

Notes: 1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 2.2mH, I_{AS} = -22A, V_{DD} = -25V, R_{G} = 25 Ω , Starting T_{J} = 25°C 3. I_{SD} ≤ -22A, I_{J} = 25°C 4. Pulse Test : Pulse width ≤ 300 μ s, I_{J} = 25°C 4. Pulse Test : Pulse width ≤ 300 μ s, Duty cycle ≤ 2% 5. Essentially independent of operating temperature

Typical Characteristics

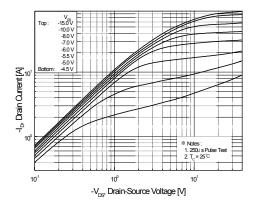


Figure 1. On-Region Characteristics

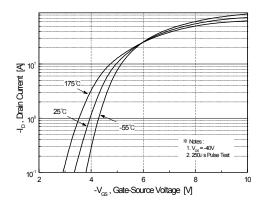


Figure 2. Transfer Characteristics

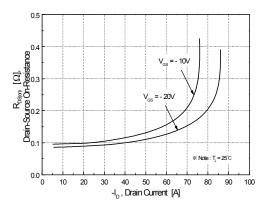


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

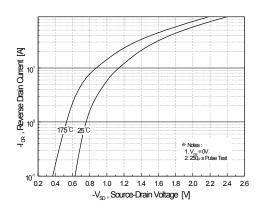


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

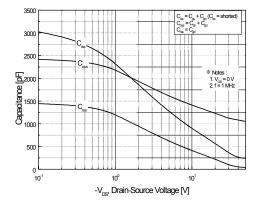


Figure 5. Capacitance Characteristics

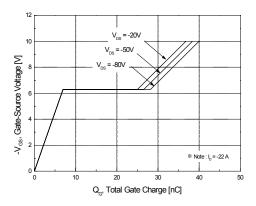
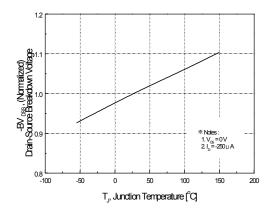


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)



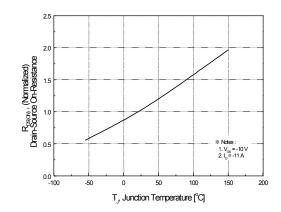
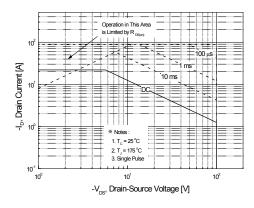


Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



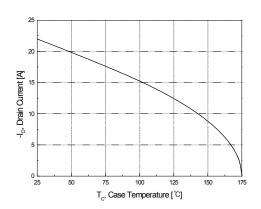


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

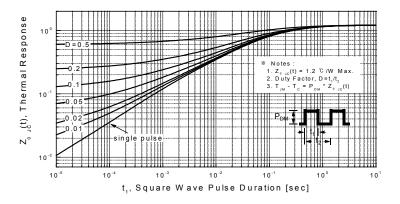
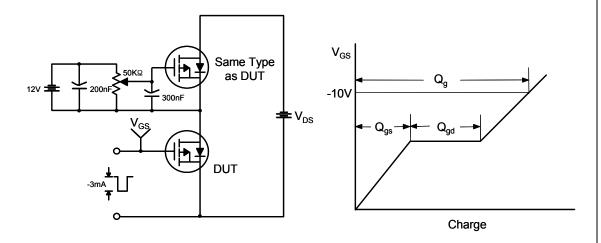
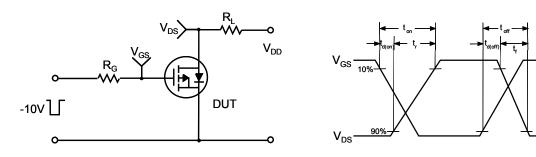


Figure 11. Transient Thermal Response Curve

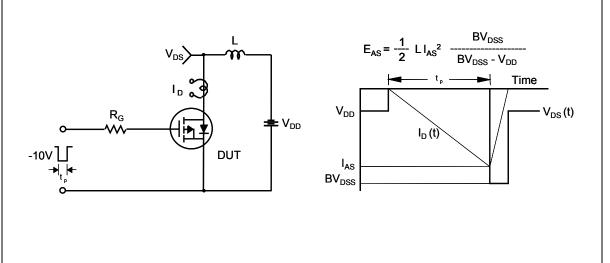
Gate Charge Test Circuit & Waveform



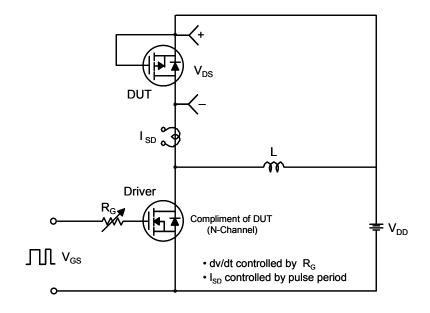
Resistive Switching Test Circuit & Waveforms

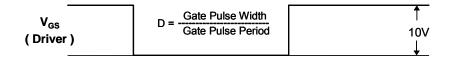


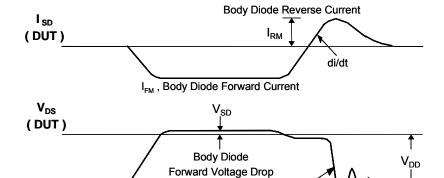
Unclamped Inductive Switching Test Circuit & Waveforms



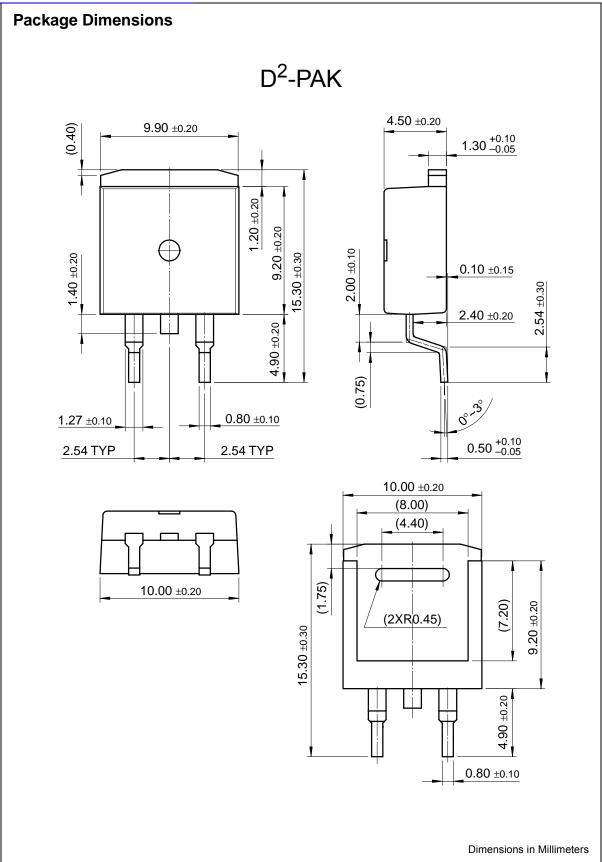
Peak Diode Recovery dv/dt Test Circuit & Waveforms







Body Diode Recovery dv/dt





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Definition of Terms					
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